

Notice of References Cited	Application/Control No. 10/809,459	Applicant(s)/Patent Under Reexamination TANAKA, YOSHIYUKI	
	Examiner Nam T. Nguyen	Art Unit 2824	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-6,784,797 B2	08-2004	Smith et al.	340/573.4
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NON-PATENT DOCUMENTS

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